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May 2014

FDMS7600AS

Dual N-Channel PowerTrench® MOSFET

N-Channel: 30 V, 30 A, 7.5 m Ω N-Channel: 30 V, 40 A, 2.8 m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 7.5 m Ω at V_{GS} = 10 V, I_D = 12 A
- Max $r_{DS(on)}$ = 12 m Ω at V_{GS} = 4.5 V, I_D = 10 A

Q2: N-Channel

- Max $r_{DS(on)}$ = 2.8 m Ω at V_{GS} = 10 V, I_D = 20 A
- Max $r_{DS(on)} = 3.3 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 18 \text{ A}$
- RoHS Compliant

General Description

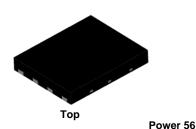
This device includes two specialized N-Channel MOSFETs in a dual MLP package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFETTM (Q2) have been designed to provide optimal power efficiency.

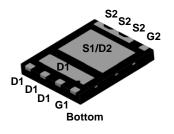
Applications

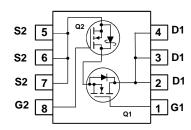
- Computing
- Communications
- General Purpose Point of Load











MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | | Q1 | Q2 | Units |
|-----------------------------------|--|------------------------|-------------------|-------------------|-------|
| V _{DS} | Drain to Source Voltage | | 30 | 30 | V |
| V_{GS} | Gate to Source Voltage (Note 3) | | ±20 | ±20 | V |
| | Drain Current -Continuous | T _C = 25 °C | 30 | 40 | |
| I _D | -Continuous | T _A = 25 °C | 12 ^{1a} | 22 ^{1b} | Α |
| | -Pulsed | | 40 | 60 | |
| В | Power Dissipation for Single Operation | T _A = 25 °C | 2.2 ^{1a} | 2.5 ^{1b} | W |
| P_{D} | | T _A = 25 °C | 1.0 ^{1c} | 1.0 ^{1d} | VV |
| T _J , T _{STG} | Operating and Storage Junction Temperature Range | | -55 to | +150 | °C |

Thermal Characteristics

| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 57 ^{1a} | 50 ^{1b} | |
|-----------------|---|-------------------|-------------------|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 125 ^{1c} | 120 ^{1d} | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 3.5 | 2 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|------------|----------|-----------|------------|------------|
| FDMS7600AS | FDMS7600AS | Power 56 | 13 " | 12 mm | 3000 units |

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Type | Min | Тур | Max | Units |
|--------------------------------------|---|---|----------|----------|----------|------------|--------------------------|
| Off Chara | octeristics | | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ $I_D = 1 mA, V_{GS} = 0 V$ | Q1 Q2 | 30 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μA, referenced to 25 °C I_D = 1 mA, referenced to 25 °C | Q1 Q2 | | 15 18 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} = 24 V, V _{GS} = 0 V | Q1 Q2 | | | 1 500 | μ Α μ Α |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = 20 V, V _{DS} = 0 V | Q1 Q2 | | | 100 100 | nA nA |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ $V_{GS} = V_{DS}, I_D = 1 mA$ | Q1 Q2 | 1 1 | 1.8 1.5 | 3 | V |
|--|---|--|----------|--------|-------------------|-------------------|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I_D = 250 μ A, referenced to 25 °C I_D = 1 mA, referenced to 25 °C | Q1 Q2 | | -6 -5 | | mV/°C |
| - | Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | Q1 | | 6.0 8.5 8.3 | 7.5 12 12 | mΩ |
| r _{DS(on)} | Drain to Source On Resistance | $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 18 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125 ^{\circ}\text{C}$ | Q2 | | 2.2 2.6 2.6 | 2.8 3.3 3.8 | 11152 |
| g _{FS} | Forward Transconductance | $V_{DS} = 5 \text{ V}, I_{D} = 12 \text{ A}$ $V_{DS} = 5 \text{ V}, I_{D} = 20 \text{ A}$ | Q1 Q2 | | 63 190 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | Q1: V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHZ | Q1 Q2 | 1315 5265 | 1750 7005 | pF |
|------------------|------------------------------|--|----------|--------------|--------------|----|
| C _{oss} | Output Capacitance | Q2: | Q1 Q2 | 445 2150 | 600 2860 | pF |
| C _{rss} | Reverse Transfer Capacitance | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHZ}$ | Q1 Q2 | 45 200 | 70 300 | pF |
| R _g | Gate Resistance | | Q1 Q2 | 0.9 0.3 | | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | Q1: | Q1 Q2 | 8.6 18 | 18 32 | ns |
|---------------------|-------------------------------|---|----------|------------|-----------|----|
| t _r | Rise Time | $V_{DD} = 15 \text{ V}, I_{D} = 12 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | Q1 Q2 | 2.5 7.6 | 10 16 | ns |
| t _{d(off)} | Turn-Off Delay Time | Q2: | Q1 Q2 | 20 45 | 32 72 | ns |
| t _f | Fall Time | $V_{DD} = 15 \text{ V}, I_D = 20 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$ | Q1 Q2 | 2.3 5.2 | 10 10 | ns |
| Qg | Total Gate Charge | V _{GS} = 0 V to 10 V Q1 | Q1 Q2 | 20 81 | 28 113 | nC |
| Qg | Total Gate Charge | $V_{GS} = 0$ V to 4.5 V $I_{D} = 15$ V, $I_{D} = 12$ A | Q1 Q2 | 9.3 37 | 13 52 | nC |
| Q _{gs} | Gate to Source Gate Charge | Q2 V _{DD} = 15 V, | Q1 Q2 | 4.3 13 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | I _D = 20 A | Q1 Q2 | 2.2 9.6 | | nC |

Electrical Characteristics $T_J = 25$ °C unless otherwise noted

| Symbol | Parameter | Test Conditions | Туре | Min | Тур | Max | Units |
|-----------------|---------------------------------------|--|----------|-----|------------|------------|-------|
| Drain-Sou | rce Diode Characteristics | | | | | | |
| V _{SD} | Source to Drain Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 12 \text{ A}$ (Note 2) $V_{GS} = 0 \text{ V}, I_S = 20 \text{ A}$ (Note 2) | Q1 Q2 | | 0.8 0.7 | 1.2 1.2 | V |
| t _{rr} | Reverse Recovery Time | Q1 I _E = 12 A, di/dt = 100 A/μs | Q1 Q2 | | 27 47 | 43 75 | ns |
| Q _{rr} | Reverse Recovery Charge | Q2 I _F = 20 A, di/dt = 300 A/μs | Q1 Q2 | | 10 80 | 18 128 | nC |

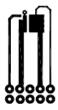
1: R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 57 °C/W when mounted on a 1 in² pad of 2 oz copper



b. 50 °C/W when mounted on a 1 in² pad of 2 oz copper



c. 125 °C/W when mounted on a minimum pad of 2 oz copper



d. 120 °C/W when mounted on a minimum pad of 2 oz copper

- 2: Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%.
- 3: As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

3

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

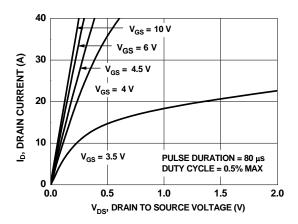


Figure 1. On Region Characteristics

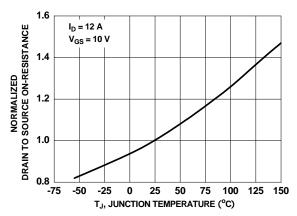


Figure 3. Normalized On Resistance vs Junction Temperature

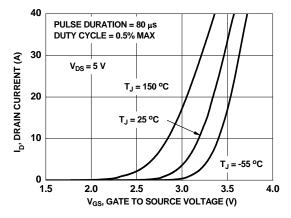


Figure 5. Transfer Characteristics

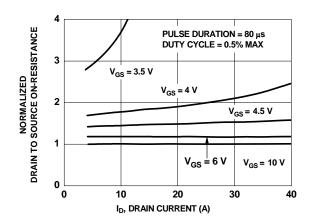


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

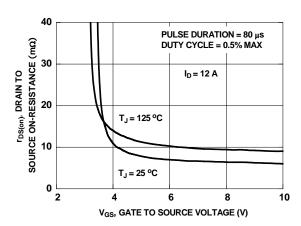


Figure 4. On-Resistance vs Gate to Source Voltage

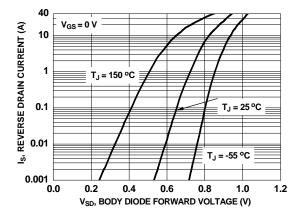


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

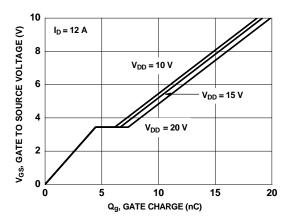


Figure 7. Gate Charge Characteristics

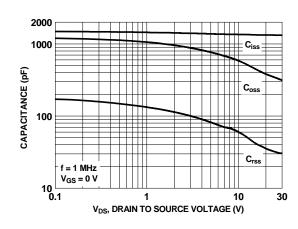


Figure 8. Capacitance vs Drain to Source Voltage

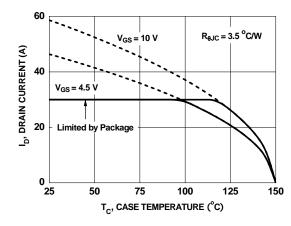


Figure 9. Maximum Continuous Drain Current vs Case Temperature

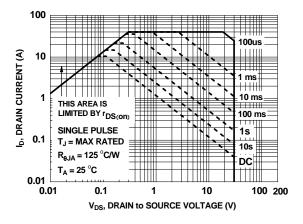


Figure 10. Forward Bias Safe Operating Area

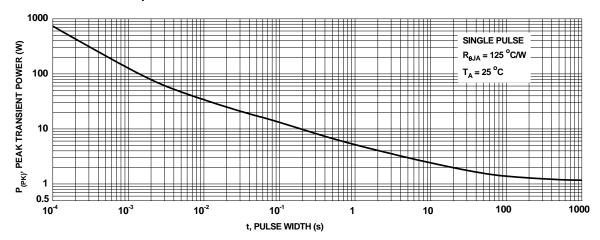


Figure 11. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q1 N-Channel) T_J = 25 °C unless otherwise noted

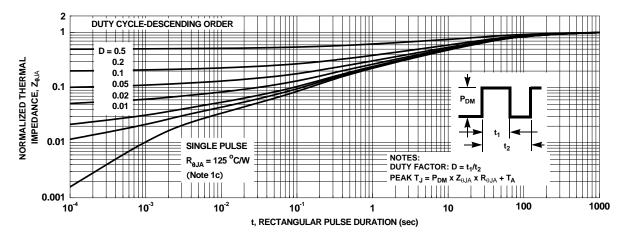


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unlenss otherwise noted

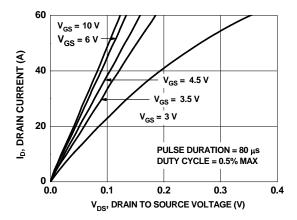


Figure 13. On-Region Characteristics

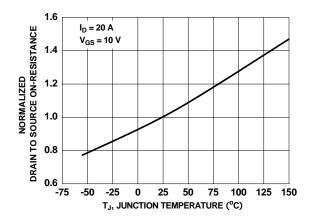


Figure 15. Normalized On-Resistance vs Junction Temperature

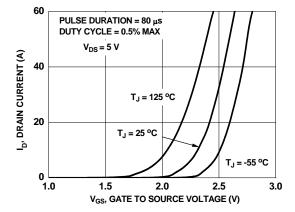


Figure 17. Transfer Characteristics

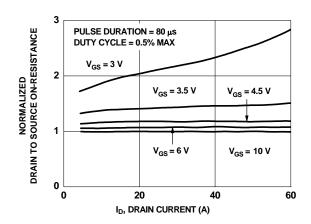


Figure 14. Normalized on-Resistance vs Drain Current and Gate Voltage

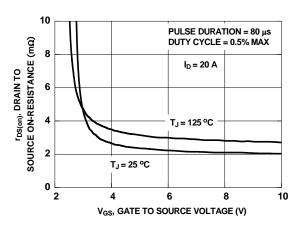


Figure 16. On-Resistance vs Gate to Source Voltage

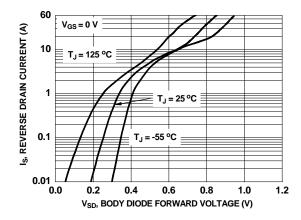


Figure 18. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q2 N-Channel) T_J = 25 °C unless otherwise noted

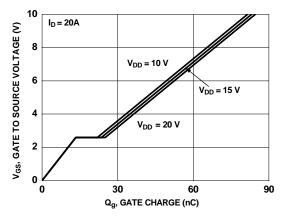


Figure 19. Gate Charge Characteristics

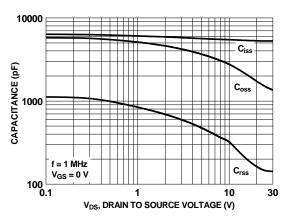


Figure 20. Capacitance vs Drain to Source Voltage

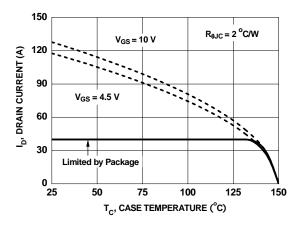


Figure 21. Maximun Continuous Drain Current vs Case Temperature

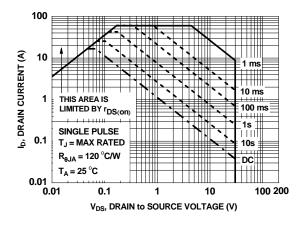


Figure 22. Forward Bias Safe Operating Area

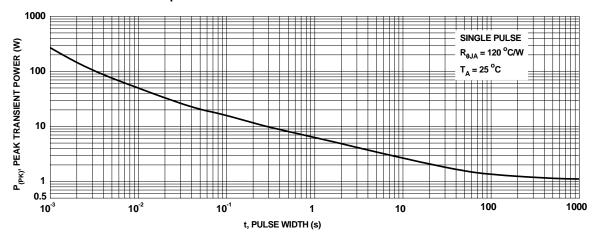


Figure 23. Single Pulse Maximum Power Dissipation

Typical Characteristics (Q2 N_Channel) $T_J = 25$ °C unless otherwise noted

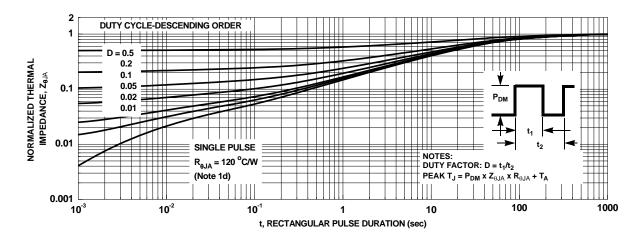


Figure 24. Junction-to-Ambient Transient Thermal Response Curve

Typical Characteristics (continued)

SyncFETTM Schottky body diode Characteristics

Fairchild's SyncFETTM process embeds a Schottky diode in parallel with PowerTrench[®] MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 25 shows the reverse recovery characteristic of the FDMS7600AS.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

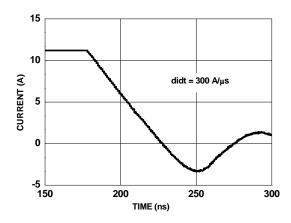


Figure 25. FDMS7600AS SyncFETTM Body Diode Reverse Recovery Characteristic

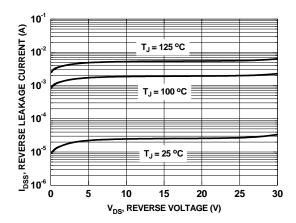
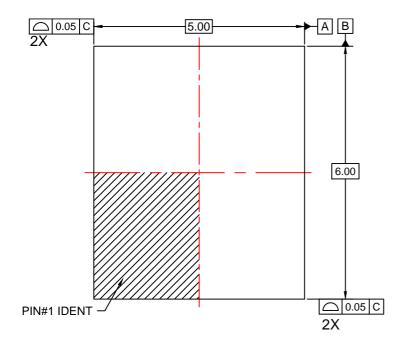
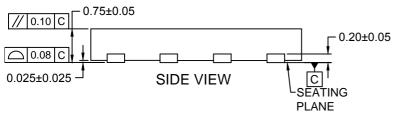
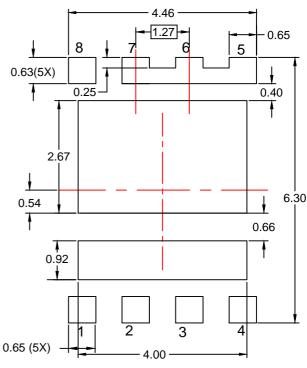


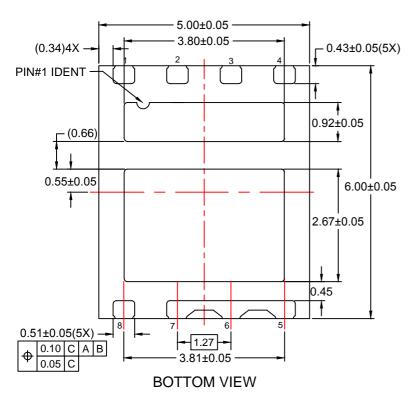
Figure 26. SyncFET[™] Body Diode Reverse Leakage vs. Drain-Source Voltage





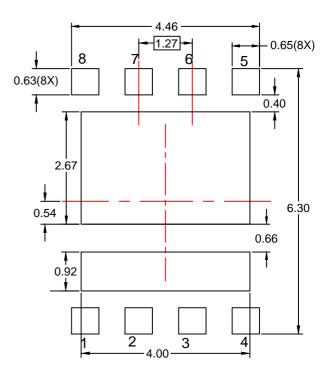


RECOMMENDED LAND PATTERN (OPTION 1 - FUSED LEADS 5,6,7)



NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Prev2.



RECOMMENDED LAND PATTERN (OPTION 2 - ISOLATED LEADS)







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PRODUCT STATUS DEFINITIONS

Definition of Terms

| Deminition of Terms | | | | | | |
|--------------------------|-----------------------|---|--|--|--|--|
| Datasheet Identification | | Definition | | | | |
| Advance Information | Formative / In Design | Datasheet contains the design specifications for product development. Specifications may change in any manner without notice. | | | | |
| Preliminary | First Production | Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. | | | | |
| No Identification Needed | Full Production | Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design. | | | | |
| Obsolete | Not In Production | Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only. | | | | |

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